

Notic of R ferenc s Cited	Application/Control No. 10/731,958		Applicant(s)/Patent Under Reexamination IGARASHI ET AL.	
	Examiner Sathyanarayan Pannala		Art Unit 2164	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,604,114 B1	08-2003	Toong et al.	707/104.1
*	B	US-6,577,807 B1	06-2003	Yaegashi et al.	386/52
*	C	US-2002/0145633 A1	10-2002	Ohmura, Akira	345/838
*	D	US-2004/0059705 A1	03-2004	Wittke et al.	707/001
*	E	US-6,483,602 B1	11-2002	Haneda, Norihisa	358/1.16
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.